



High-Accuracy Surface Scanning Method

High resolution of 0.000012" (0.3 μm)

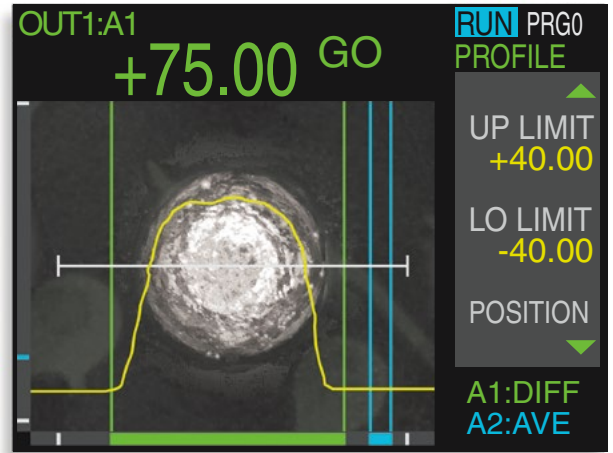


The high-accuracy, surface scanning method allows measurements of all types of targets

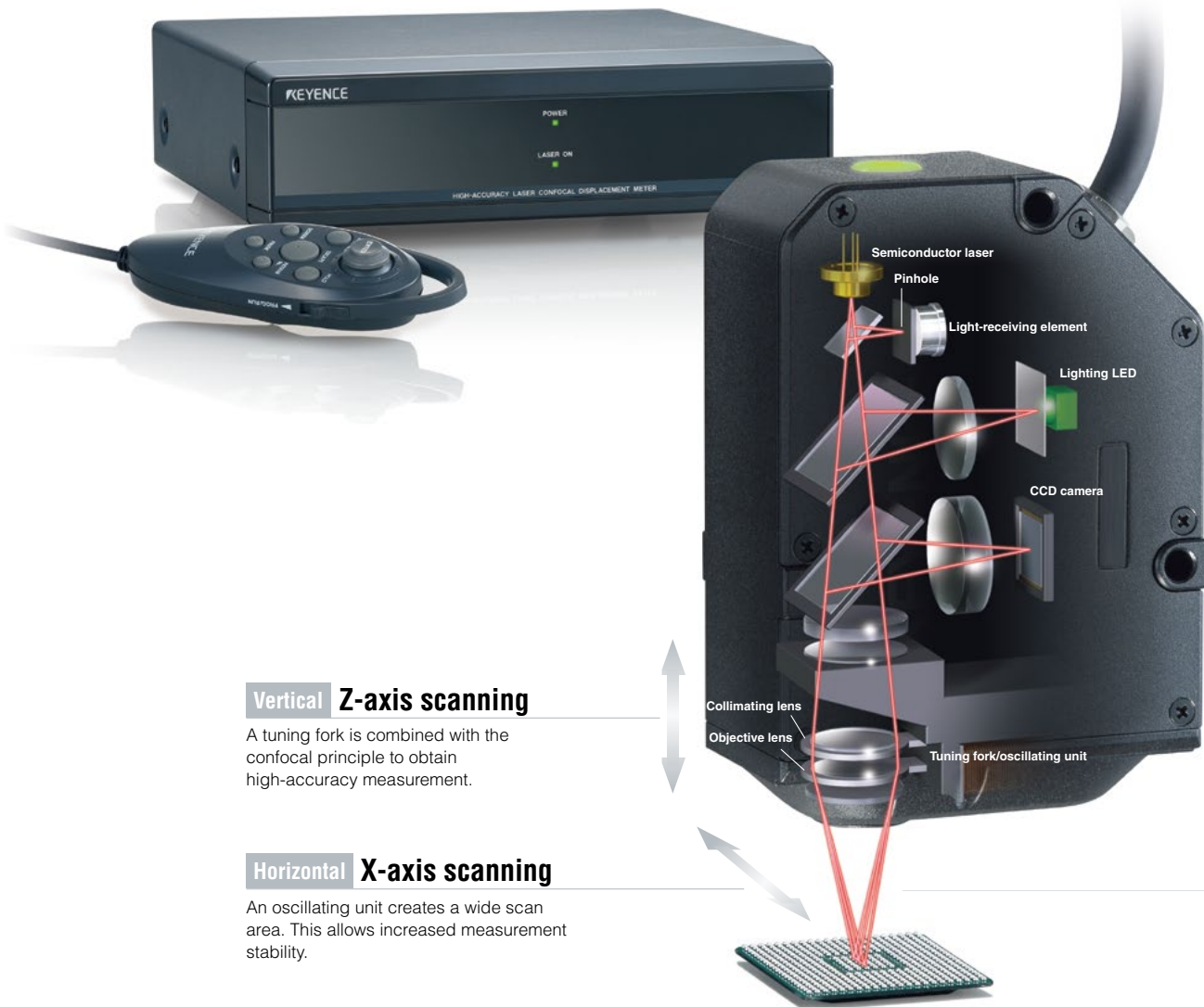
A tuning fork unit and oscillating unit are combined to create a surface scanning laser. This results in advanced displacement and profile measurements that are unaffected by target color or angle.

Surface Scanning Laser
Confocal Displacement Meter

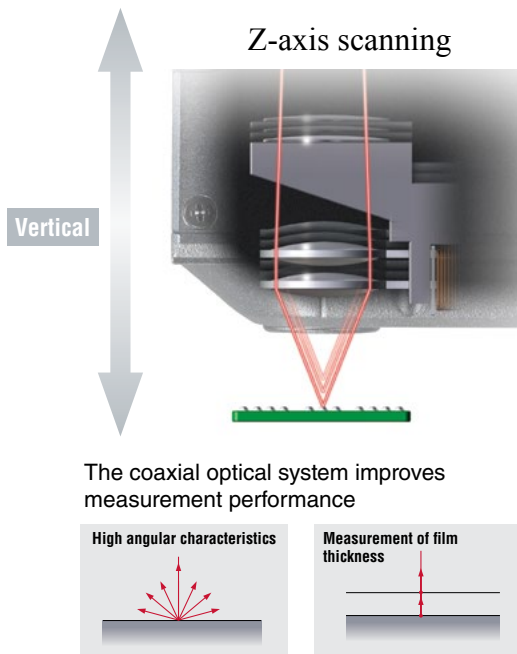
LT-9000 Series



BGA profile measurement



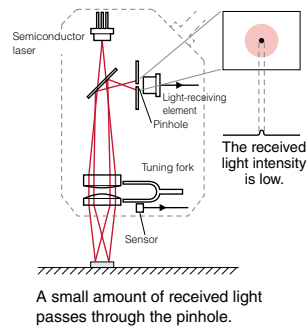
Excellent resolution of 0.000012" (0.3 μm) for high-accuracy applications



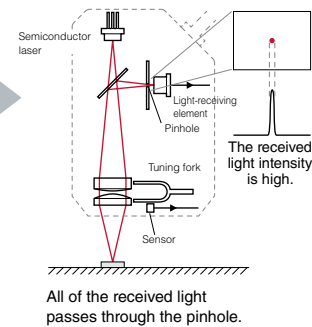
High-accuracy measurement method uses the confocal principle and tuning fork

The laser beam is focused on the target surface through an objective lens that vibrates up and down at high speed by means of a tuning fork. The beam reflected off the target surface is converged on a pinhole and then enters the light-receiving element. By measuring the exact position of the objective lens when the light enters the light-receiving element, the target height can be determined. The sensor measures the distance to the target surface accurately without being affected by the material, color, or angle of the target.

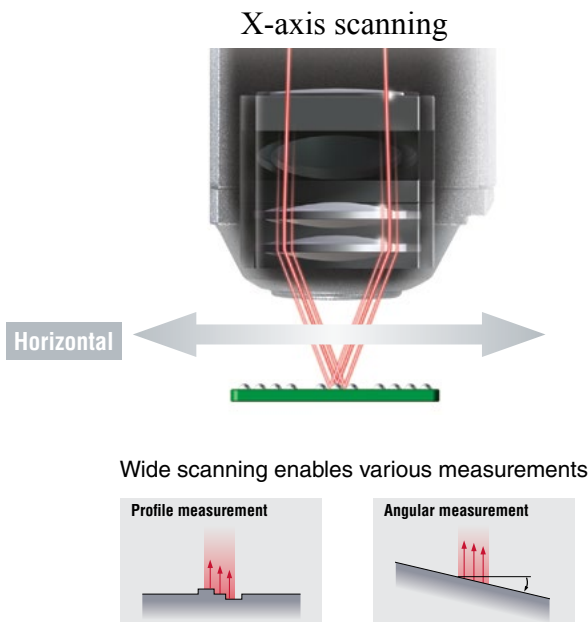
When focus is not obtained on the target surface



When focus is obtained on the target surface

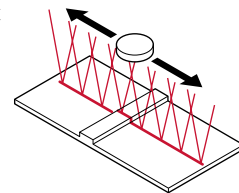


New wide scanning feature increases measurement stability and versatility



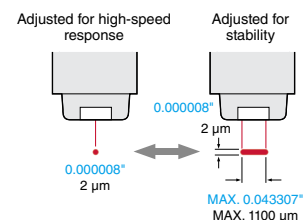
High-accuracy scanning using the oscillating unit

The 0.000008" (2 μm) laser beam spot can be scanned horizontally for up to 0.043307" (1100 μm) by using the high-accuracy oscillating mechanism. This new scanning method enables measurements of profile, angle, and area.



Adjustable scanning width according to the application

The scanning width of the laser beam can be changed freely according to the application and the surface condition of the target. In addition, highly stable displacement measurements are ensured by calculating the scanning data.



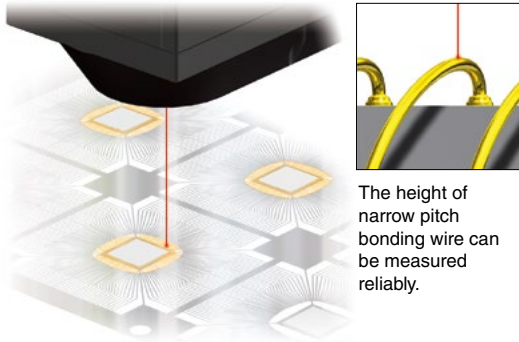
A variety of high accuracy measurements are possible.

Typical applications for the LT-9000 Series

Microscopic targets

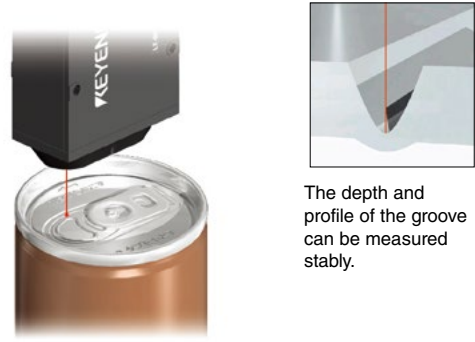
A small spot size enables the measurement of microscopic points.

Measuring the height of wire



The height of narrow pitch bonding wire can be measured reliably.

Measuring the score depth of a pull-tab

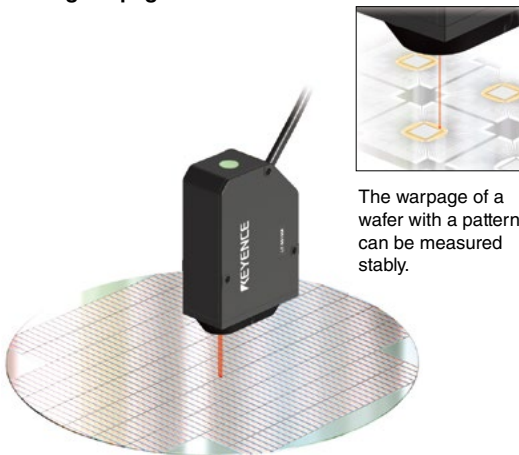


The depth and profile of the groove can be measured stably.

Rough-surfaced targets

The light intensity integration function and laser scanning method offer high stability.

Measuring warpage of a wafer



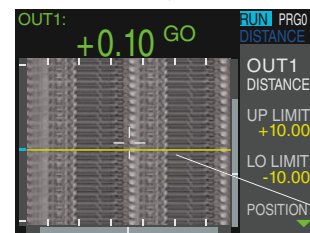
The warpage of a wafer with a pattern can be measured stably.



When the laser scanning method is disabled:

The measurement is affected by the pattern on the surface.

The measurement value is unstable due to the influence of the surface conditions.



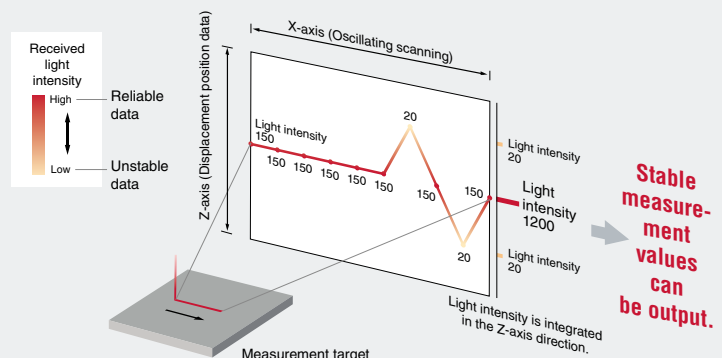
When the laser scanning method is enabled:

Accurate measurement is obtained by eliminating the influence of the pattern.

The measurement value is stable, enabling the measurement of the warpage profile.

The light intensity integration function — Provides high stability

1. The 0.00008° ($2\ \mu\text{m}$) beam spot is shifted in the X-axis direction with the movement of the oscillating unit.
2. The data of each spot in the X-axis direction is divided into two categories: the displacement position data (Z-axis) and the light intensity data.
3. Data is obtained from the rough surface of the target, in which stable data with high received light intensity and unstable data with low received light intensity are mixed. The light intensity integration function further enhances the difference of the light intensity by integrating the light intensity of the Z-axis direction, and it outputs stable displacement position data unaffected by the unstable data with low received light intensity.

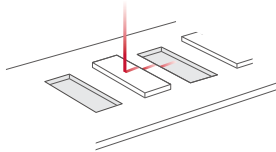


Multiple measurement modes for a wide range of applications

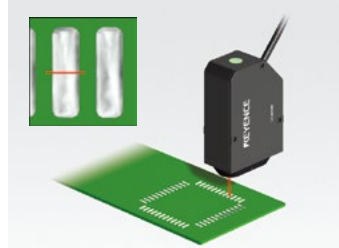
Profile measurement

The surface profile can be traced accurately using the oscillating unit.

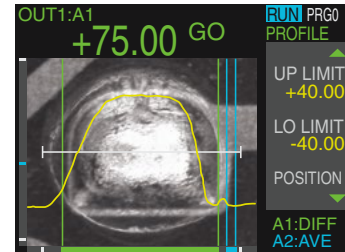
Measuring the profile of solder paste on a PWB



The surface profile can be traced using the double-scanning method. The height difference between the two points can be measured.

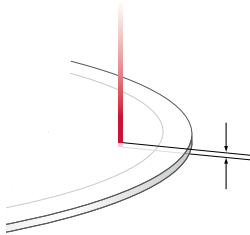


The profile of lead-free solder can be measured for detecting abnormalities such as cracks, bridges, and insufficient soldering.



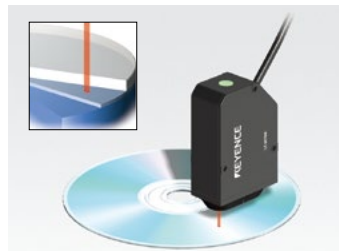
Transparent object thickness measurement

The surface condition, film thickness, and thickness of transparent objects can be measured stably by utilizing the confocal principle.

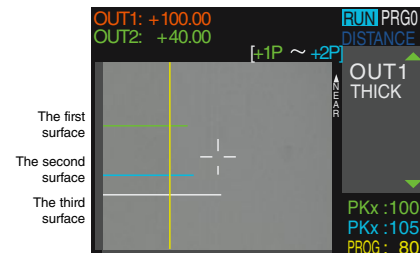


The surface condition, film thickness, and thickness of transparent objects can be measured. In addition, the **slant correction function** enables more reliable measurements.

Measuring the thickness of an optical disc

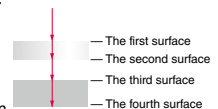


The intermediate layer of an optical disc can be measured.



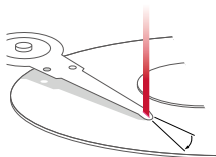
Multi-surface measurement function

The peak value of light intensity of up to four points can be detected with one measurement unit. The selected measurement surface can be measured with high accuracy.

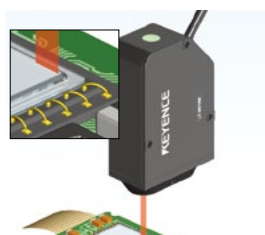


Angle measurement

Measuring the parallelism of a CCD and cover glass



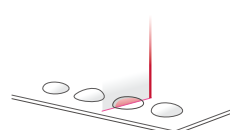
An angle can be measured in increments of 0.01 degrees based on the measurement values of two or more points obtained by scanning the laser beam spot.



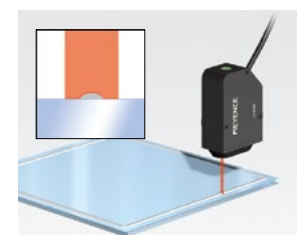
The inclination of a CCD surface against the rear surface of the glass can be measured accurately using the newly developed relative angle measurement.

Measurement of a cross-sectional area

Measuring the cross-sectional area of liquid sealing material



The cross-sectional area can be determined based on the cross sectional profile obtained by scanning the laser beam spot.



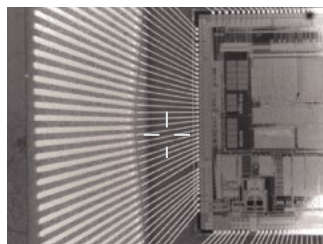
The profile and cross-sectional area of sealing material applied for bonding glass substrates.

Quick and easy setup functions

Microscope function — Employing a high-speed auto-focus lens for clear images

An ultra-compact CCD camera is incorporated in the sensor head. The target image can be enlarged approximately 85 times* on the monitor screen. The special optical design provides sharp images, allowing easy positioning of microscopic targets.

(* When using special monitor CA-MN81)



IC chip



Image of phoenix on a 10-yen coin

Monitor for measured value and waveform display — For real-time display of measured values and waveform

Observations of displacement and profile data can be performed with ease.



Soldered area of leads



Engraved mark

Simplified setup menu — Simple operation using special remote console

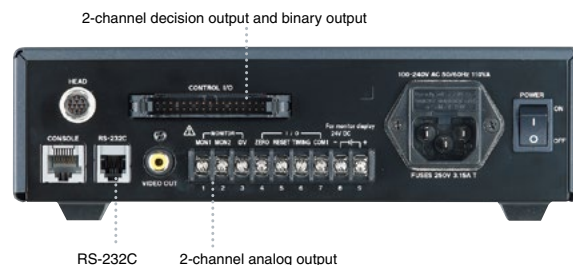
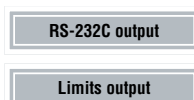
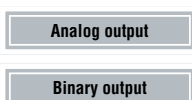
The special remote console and user-friendly setup menu greatly simplify the setup process. Measurement can begin just minutes after unpacking the box.



Multiple I/O options come standard — For enhanced operational flexibility

All of the necessary interfaces including 2 channels of analog outputs, RS-232C output, 2 channels of decision outputs, and binary outputs are incorporated as standard into the compact housing.

(Only half the size of conventional models.)

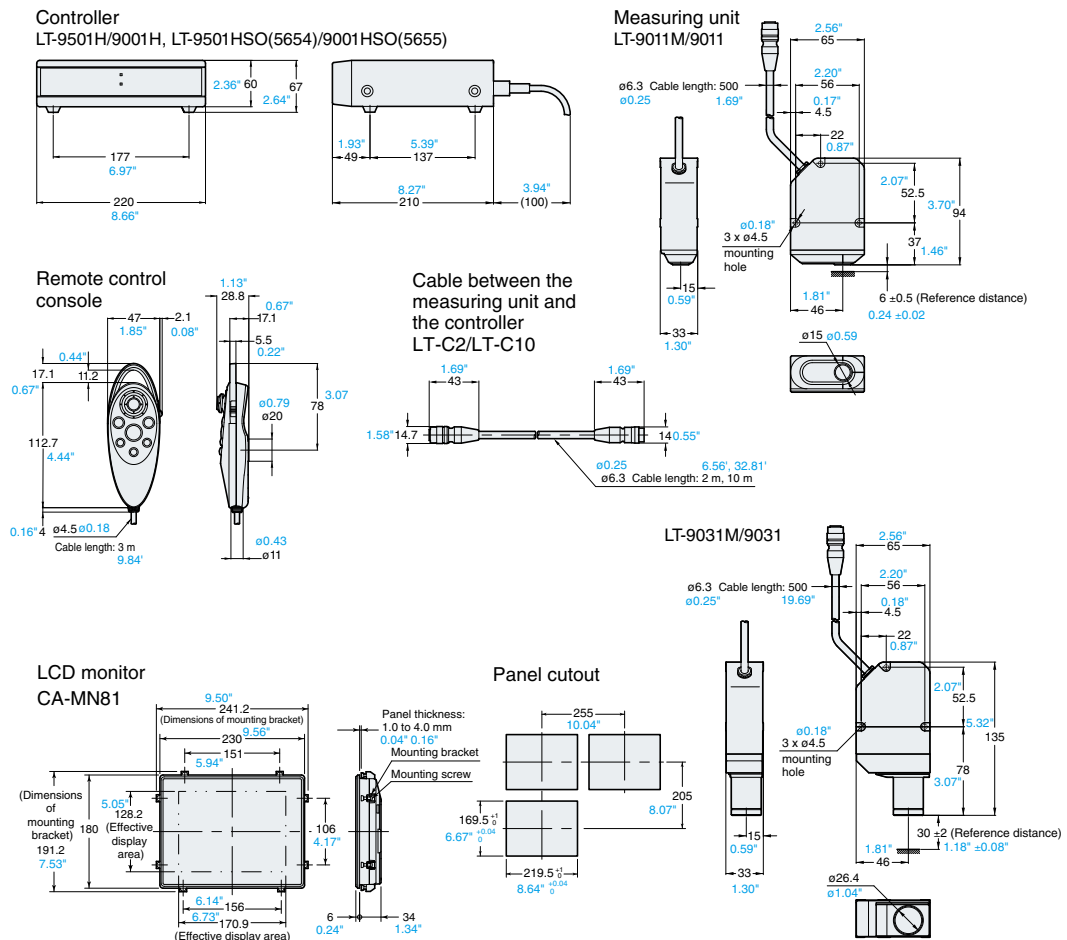


System configuration



Unit: mm Inch

Dimensions



New features of the LT-9000 Series

Interchangeable sensor head and controller

A CPU is built into the sensor head so that the sensor head and controller become interchangeable. The calibration data and other information of the sensor head is digitally transferred to the controller. Complicated adjustments are no longer required upon replacement.

Calibration function

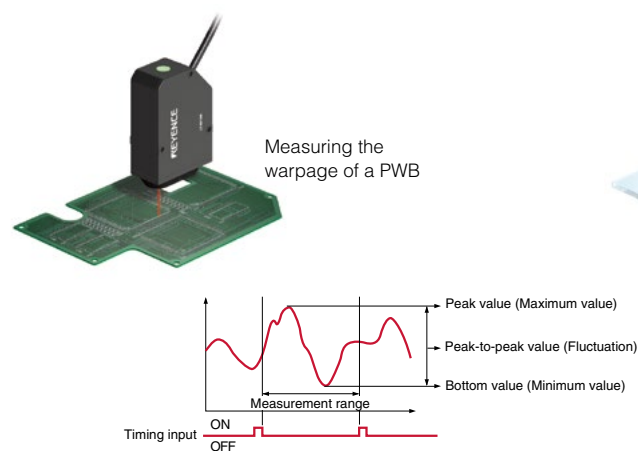
The measured values can be calibrated by using a reference target. Since logical calibration can be performed using numerical values, optimal adjustment can be made according to the details of the actual target measurements.

Up to 65.6' (20 m) cable extension

Wiring can be extended up to 65.6' (20 m) by adopting the digital method for communications between the controller and sensor head. This greatly enhances the installation flexibility.

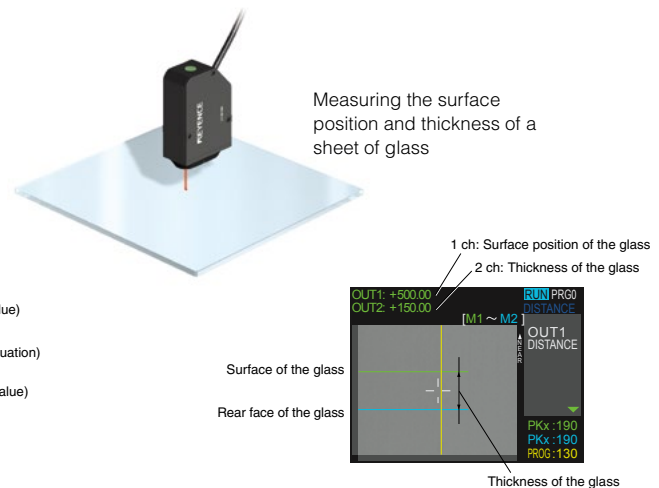
Various measurement modes

The LT-9000 Series features 9 types of measurement hold modes, including Peak hold, Bottom hold, and Peak-to-peak hold mode. The mode can be set up as desired according to the application without using an analog controller or PLC.



2-channel simultaneous measurement

The measurement of two different points can be performed simultaneously. The surface position and thickness of glass can be measured and displayed at the same time.



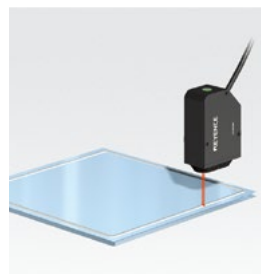
Applications by industry

Automotive industry



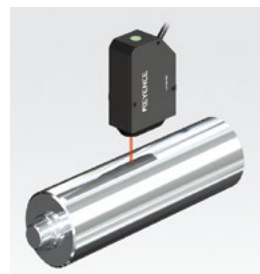
Measuring the surface profile of a brake disc

LCD industry



Measuring the cross-sectional area of liquid sealing material on LCD glass

Print industry



Measuring the cell depth of a print roll

Plastic industry



Measuring the thickness of a contact lens

Specifications

Controller

Model	Controller	LT-9501H/LT-9001H	LT-9501HSO(5654)/LT-9001HSO(5655)
	Measuring unit	LT-9011M/LT-9011	LT-9031M/LT-9031
Measuring unit compatibility		Measuring units are interchangeable without factory recalibration.	
Display	Minimum display unit	0.1 μm , 1 μm^2 , 0.01°	0.1 μm
	Display range	$\pm 9999.99 \mu\text{m}$, $\pm 999999 \mu\text{m}^2$, $\pm 9999.99^\circ$	$\pm 9999.99 \mu\text{m}$
	Microscope function	Available (LT-9501H only)	Available (LT-9501HSO(5654) only)
	Display cycle ¹	10 times/sec.	
Terminal block	Analog output	$\pm 10 \text{ V}$ x 2 outputs, output impedance: 100 Ω	
	Timing input/Reset input/Auto-zero input	Non-voltage input	
	Monitor dedicated power supply ²	24 VDC, 1 A	
Control I/O	Limits mode ³	3-step limits output	For OUT1 and OUT2, and NPN open collector output
	Binary mode ³	Binary output	Measured data output (21 bits), OUT1/OUT2/PROFILE selectable NPN open collector output
		Strobe output	NPN open collector output
		Binary selection output	NPN open collector output
		Binary selection input	Non-voltage input
	Stability output	NPN open collector output	
	Laser remote input	Non-voltage input	
	Program change input	Non-voltage input x 3 inputs	
RS-232C interface		Measured data output and control I/O (Selectable up to baud rate 115200 bits/s.)	
Video output		NTSC compliant (PIN connector)	
Main function	Distance mode ⁴	Distance measurement, Transparent object thickness measurement, Angle measurement, Relative angle measurement, Surface selection, Dark-out, Mask, Trend graph display, and Scan width/interval change	Distance measurement, Transparent object thickness measurement, Surface selection, Dark-out, Mask, Trend graph display, and Scan width/interval change
	Profile mode ⁴	Area selection (Average, Maximum, Minimum, Maximum-to-minimum, Area) Area calculation, Scan width/interval change, Dark-out, Smoothing, Averaging, and Profile data output	—
	Common	Light intensity accumulation, Microscope (LT-9501H, LT-9501HSO (5654) only), Tolerance judgment, 8-program registration, Calibration, Averaging, Hold modes, Auto-zero, and interface language selection	
Rating	Power supply voltage	100 to 240 VAC $\pm 10\%$ 50/60 Hz	
	Current consumption	110 VA or lower	
	Overvoltage category	II	
	Pollution degree	2	
Ambient temperature		0 to 35°C (32 to 95°F), No condensation	
Relative humidity		35 to 85%, No condensation	
Weight		Approx. 2.4 kg	

1. Varies depending on the setting

2. Dedicated power supply for the monitor specified by KEYENCE.

3. Select either the Limits mode or the Binary mode.

4. Select either the Distance mode or the Profile mode. (Distance mode is only available with the LT-9501HSO(5654) and LT-9001HSO(5655).)

The rating of the NPN open-collector output is 30 mA (30 V or lower) maximum, and residual voltage is 0.5 V.

The rating of the Non-voltage input is ON voltage 1 V or lower, and OFF current 0.6 mA or lower.

Cable between the sensor head and controller (Extension cable)

Model	LT-C2	LT-C10
Cable length	6.56' 2 mm	32.81' 10 mm
Weight	Approx. 200g	Approx. 700g

* Up to 3 cables can be connected with a total maximum length of 65.6' (20 m).

Measuring Unit

Type	High-accuracy		Long-range	
Model	LT-9011M	LT-9011	LT-9031M	LT-9031
Measurement range	0.01" ±0.3 mm		0.04" ±1.0 mm	
Reference distance	0.24" 6 mm		1.18" 30 mm	
Light source	Visible red semiconductor laser			
	Wavelength	655 nm		
	Output	3.0 μW (FDA (CDRH) Part1040.10), 170 μW (IEC60825-1)		
	Laser Class	Class IIa (FDA (CDRH) Part1040.10), Class1 (IEC60825-1)		
Spot diameter		Approx. ø0.000079" ø2 μm	Approx. ø0.000276" ø7 μm	
Scan width/interval	0 to 0.0433" 0 to 1100 μm (6 steps)/ 0.000039" to 0.000394" 1 to 10 μm (4 steps)		0 to 0.022047" 0 to 560 μm (6 steps)/ 0.000039" to 0.000315" 1 to 8 μm (4 steps)	
Resolution ¹ .	0.000012" 0.3 μm			
Linearity ¹ .	±0.5% of F.S.		±0.3% of F.S.	
Sampling cycle ³	640 μs to 356 ms (14 steps)		640 μs to 187 ms (14 steps)	
Temperature characteristics (+20 to +30°C(+68 to +86°F))	±0.5% of F.S.		±0.25% of F.S.	
Microscope function	Available	Unavailable	Available	Unavailable
	Field of view 0.05" x 0.04" 1.3 mm x 1.05 mm	—	0.10" x 0.08" 2.5 mm x 2.0 mm	—
	Illumination light source Infrared LED (wavelength: 870 nm)	—	Infrared LED (wavelength: 870 nm)	—
Ambient light	Incandescent lamp/fluorescent lamp: 10000 lux max.			
Ambient temperature	0 to 35°C (32 to 95°F), No condensation			
Relative humidity	35 to 85%, No condensation			
Weight	Approx. 400g		Approx. 500g	

1. The value when the measurement target is an mirrored surface object that is measured in displacement mode, scan width/interval 0.004724" (120 μm)/0.000079" (2 μm), and 8-times average.

2. The value when the FINE mode is set to OFF.

3. Sampling cycle differs according to the manufacturing variation of individual measuring units.

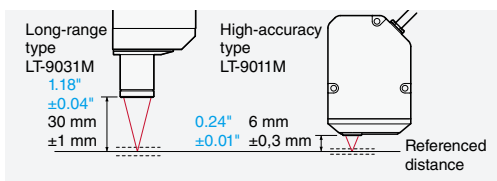


Long-range type

LT-9031M

Long range type for more flexible installation

- Long range of up to **1.18"** (30 mm)
- Measuring range of **-0.04" to +0.04"** (-1 to +1 mm)
- Smallest beam spot of **0.000276"** (7 μ m)
- Resolution of **0.000012"** (0.3 μ m)



Warning

The LT-9000 Series conforms to the FDA standard for Class IIa and IEC standard for Class 1 laser products.



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SAFETY INFORMATION

Please read the instruction manual carefully in order to safely operate any KEYENCE product.

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